**Q** 

## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10630438	TSURUOKA, TAKAO
Examiner	Art Unit
Henn, Timothy J	2622

SEARCHED			
Class	Subclass	Date	Examiner
348	241,243,245,246	2/17/07	TJH
382	254,260,270-273	2/17/07	TJH

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted QEM Re: Variance and Temperature	2/17/07	TJH		
Consulted Yogesh Aggarwal Re: Thresholds	2/17/07	TJH		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	